Blind CRESST Data Analysis in the light of Time-Dependent Noise

Florian Reindl

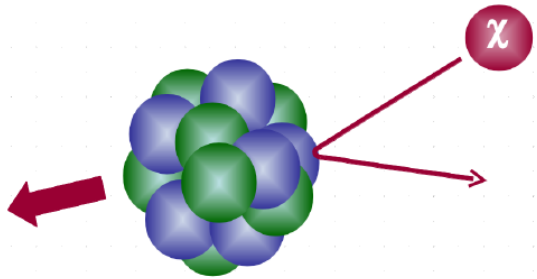
Technische Universität München
Max-Planck-Institut für Physik München

IMPRS Workshop on Nov 14th, 2011

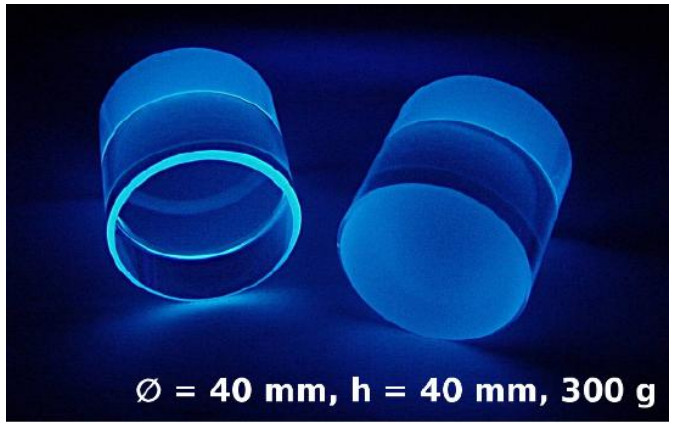
Direct Dark Matter Search with the CRESST Experiment

CRESST

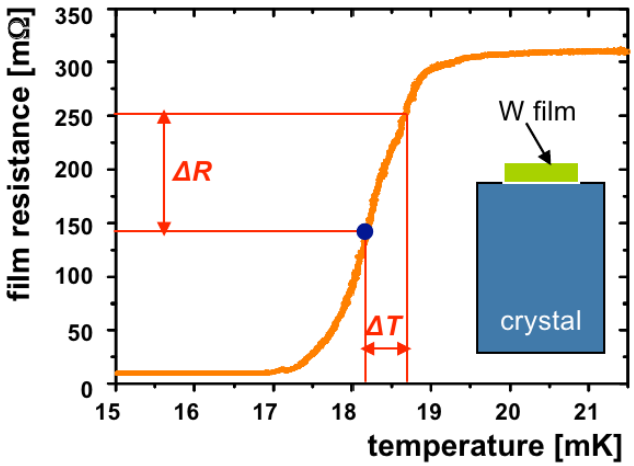
- aims for a WIMP detection via their elastic scattering off nuclei.



- uses scintillating $CaWO_4$ crystals as target material.

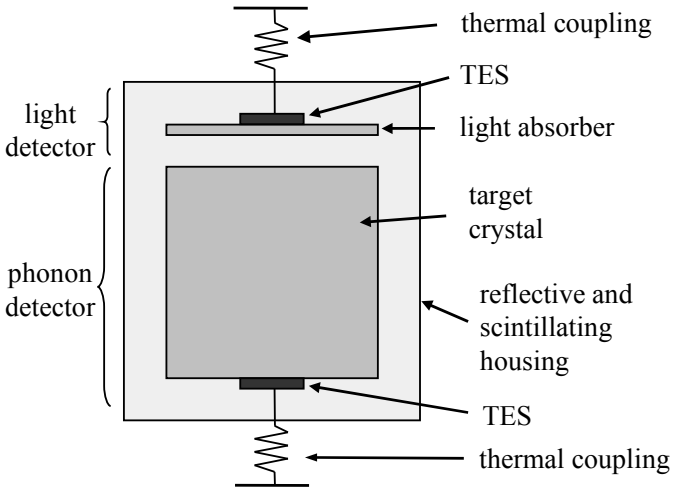


CRESST Detectors



- particle interactions in the crystal excite phonons
- temperature rise detected with Transition Edge Sensor (TES)

$\Rightarrow$ measurement of deposited energy (few keV)

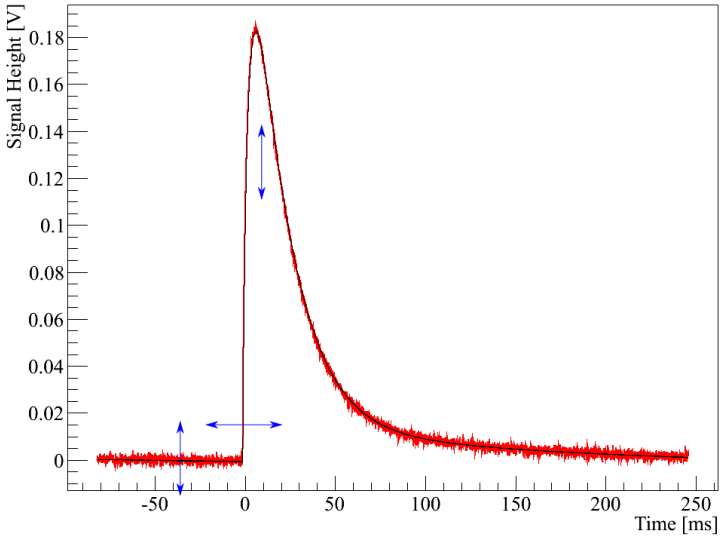


detector module:
simultaneous measurement of

- energy in crystal E
- scintillation light L

$\Rightarrow$ active background discrimination by light yield ($\frac{L}{E}$)

Standard Template Fit & RMS



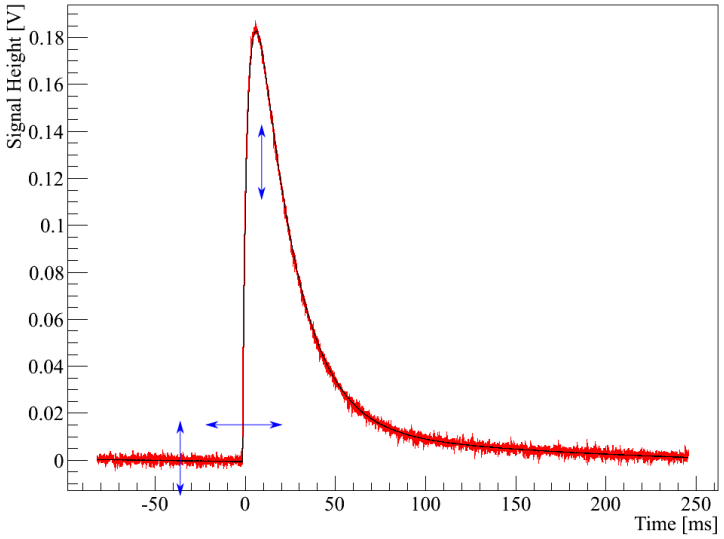
- thermal pulse: fit with standard event

$\Rightarrow$ Amplitude $\rightarrow$ Energy

$\Rightarrow$ "RMS of Fit [V]"

- The RMS is the only generic parameter to find events with different pulse shapes.

Standard Template Fit & RMS

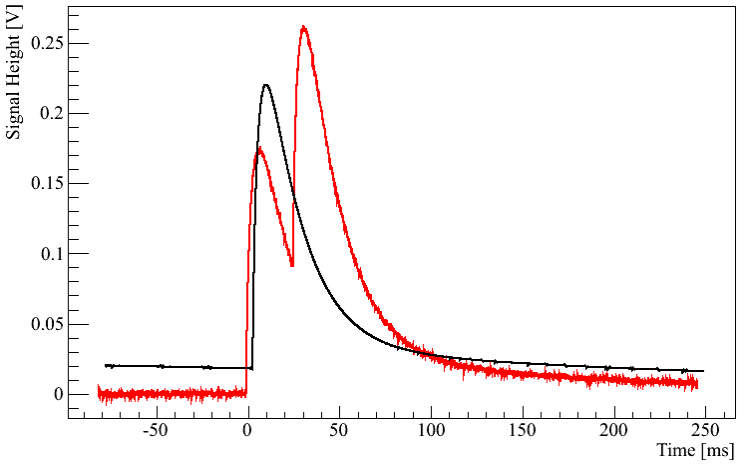


- thermal pulse: fit with standard event

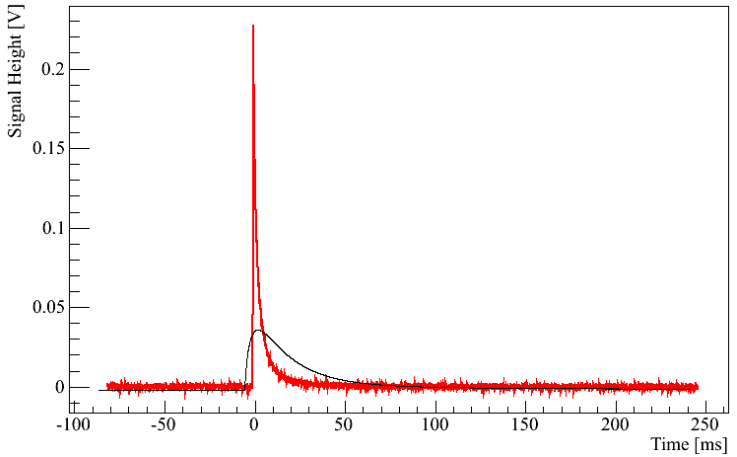
$\Rightarrow$ Amplitude $\rightarrow$ Energy

$\Rightarrow$ "RMS of Fit [V]"

- The RMS is the only generic parameter to find events with different pulse shapes.



pile-up



direct hit of thermometer carrier

Blind Analysis & Contributions to the RMS

Blind Analysis

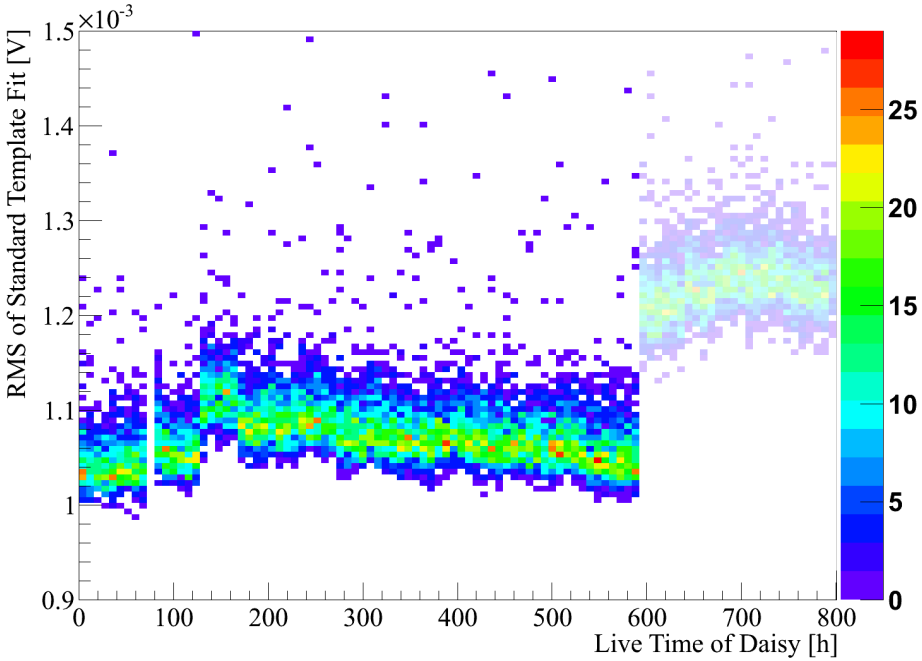
- Use small subset of whole data set to develop cuts → **Training Set**
- Application of cuts on data set without changes → **Blind Analysis**

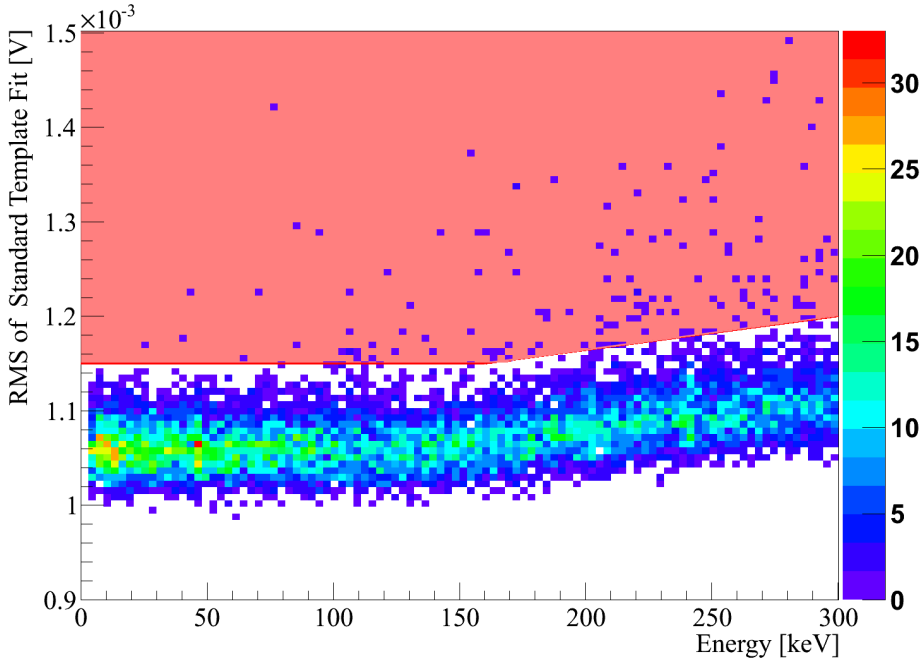
Distinctive feature of the RMS

Two contributions:

1. differences in pulse shape between pulse and template
2. noise

Time and Energy Dependence

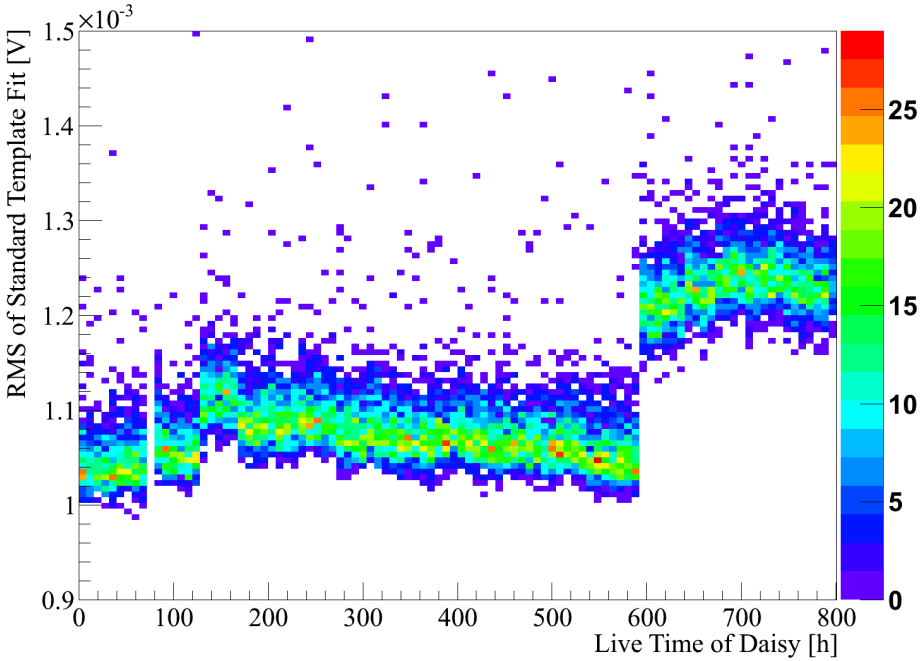


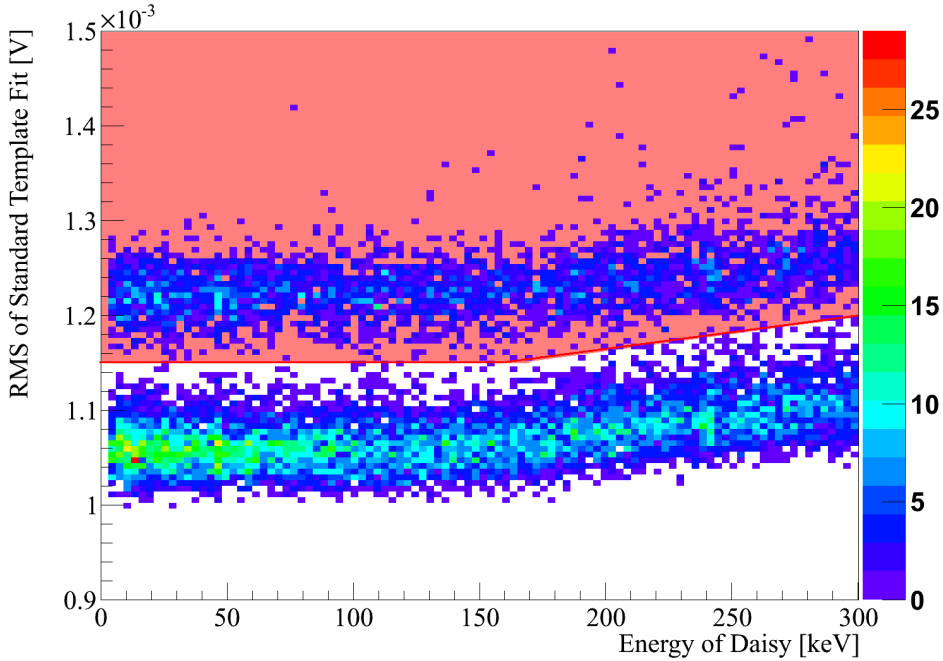


- previous analyses: polygon cut to solve energy dependence
- time dependence prevents development of polygon cut on training set
- adjustment of the polygon cut on data set necessary

→ completely blind analysis impossible

Time and Energy Dependence

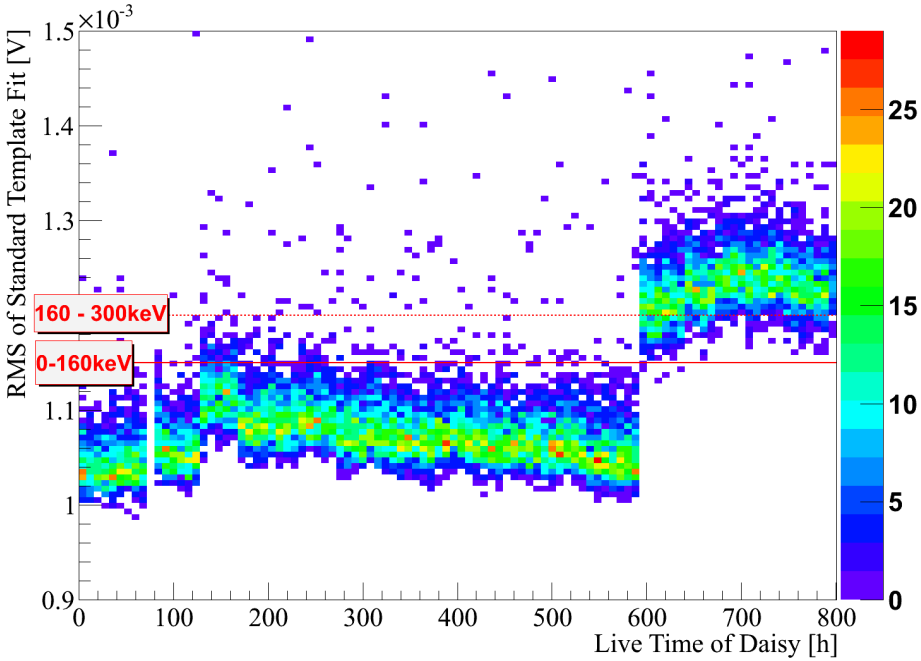


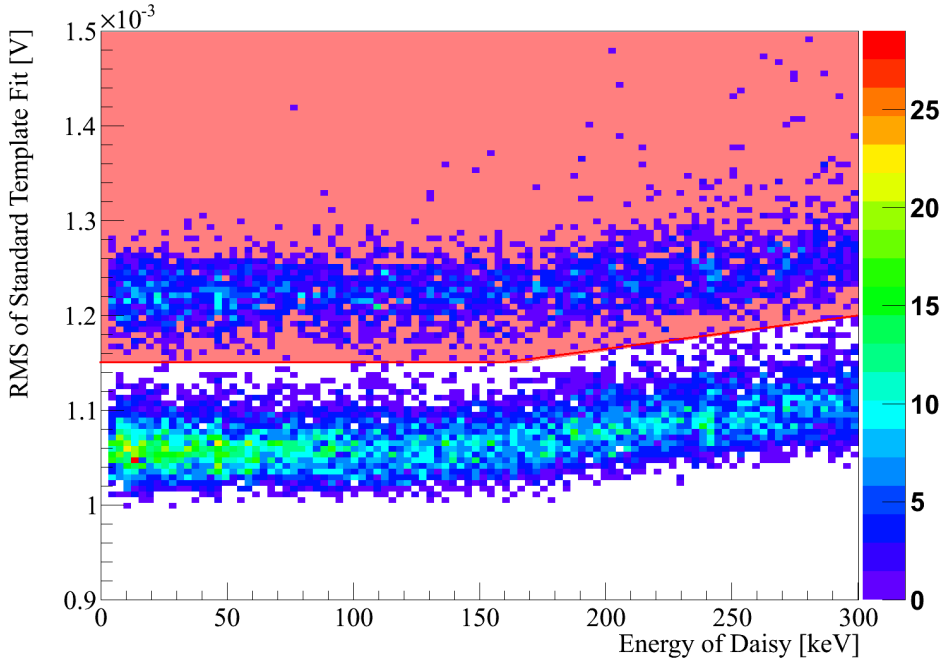


- previous analyses: polygon cut to solve energy dependence
- time dependence prevents development of polygon cut on training set
- adjustment of the polygon cut on data set necessary

→ completely blind analysis impossible

Time and Energy Dependence

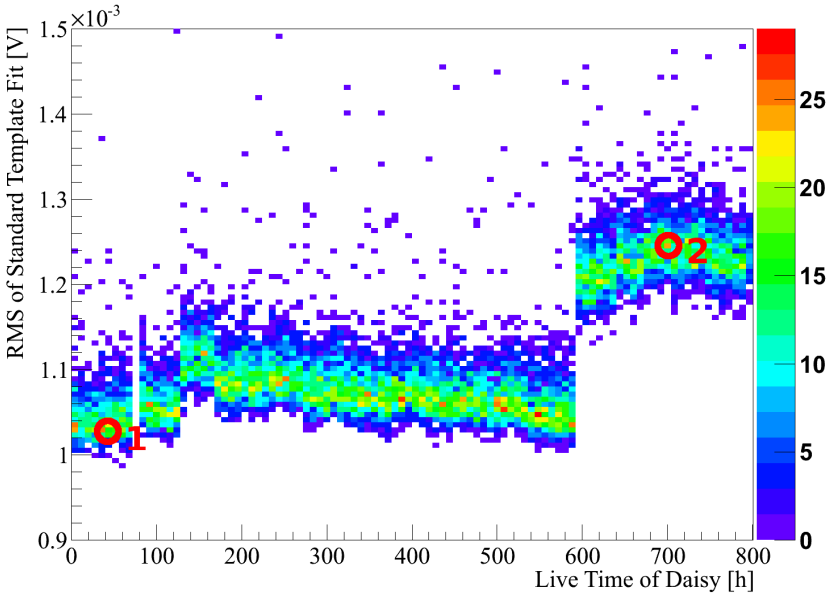


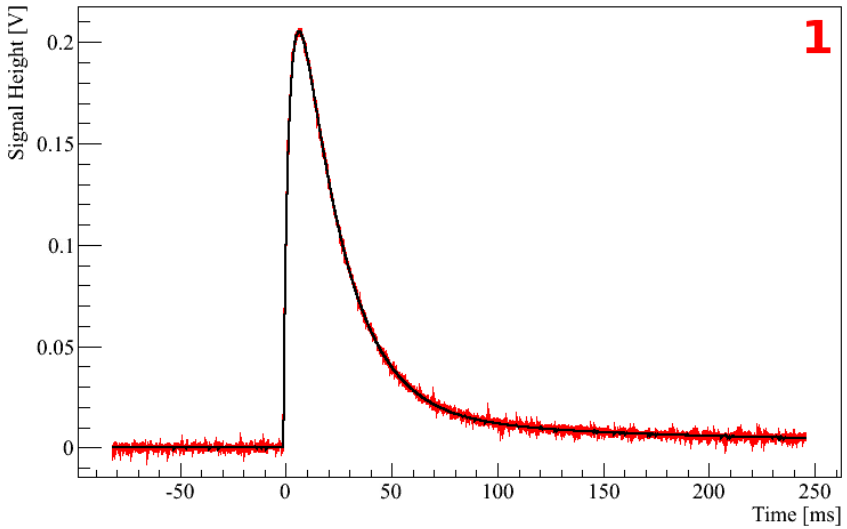


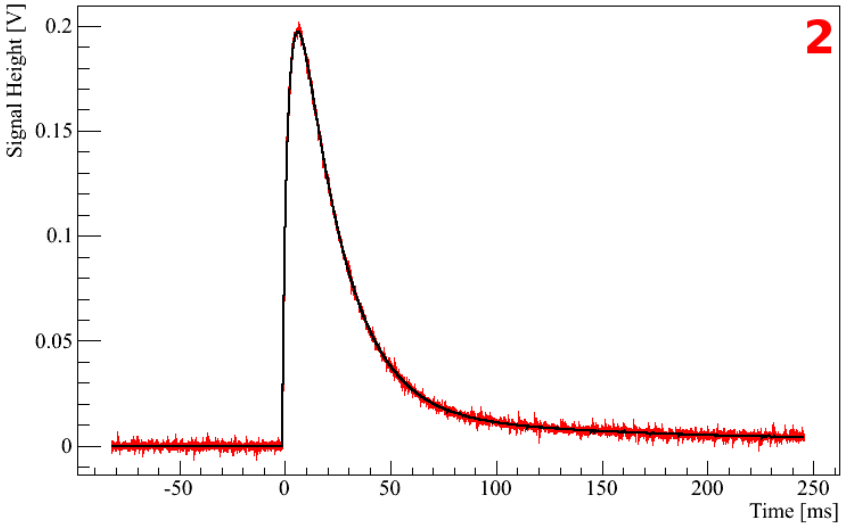
- previous analyses: polygon cut to solve energy dependence
- time dependence prevents development of polygon cut on training set
- adjustment of the polygon cut on data set necessary

→ completely blind analysis impossible

Fit Examples

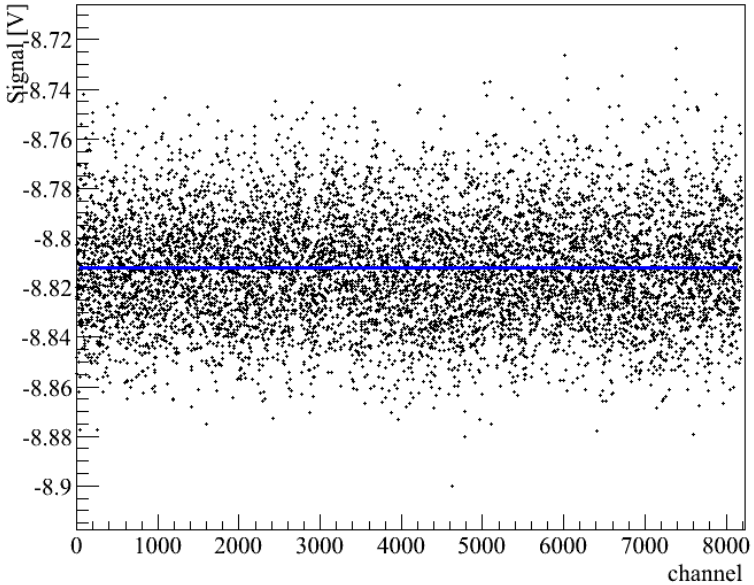






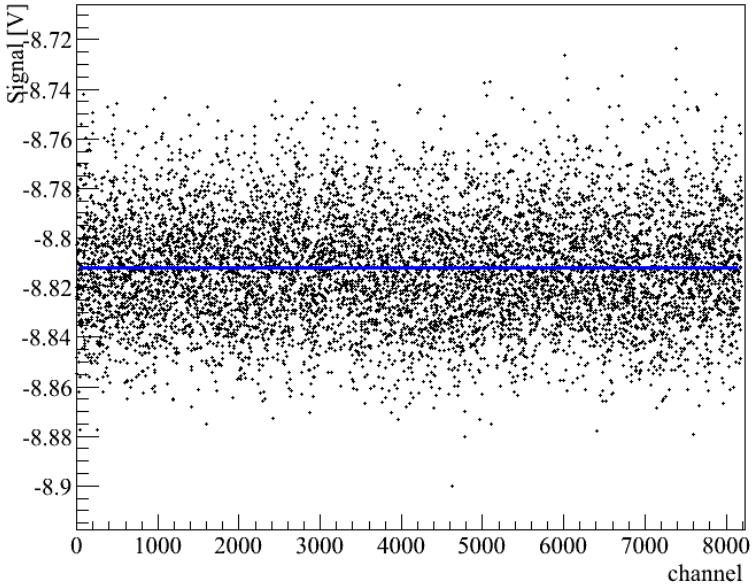
- nearly no influence of moderate noise changes to energy resolution
- adjustment of RMS cut to current noise level needed

Empty Baselines

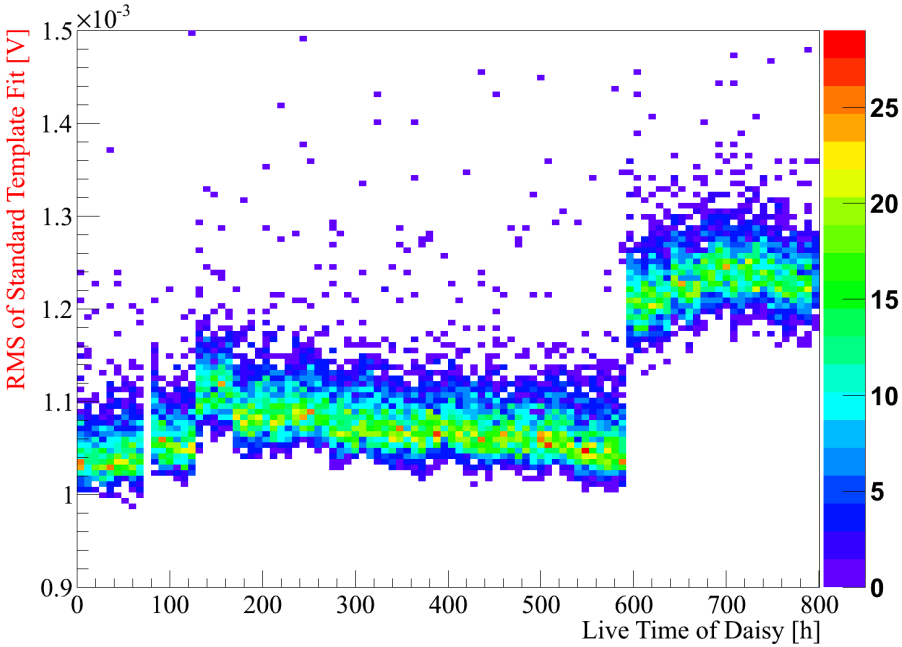


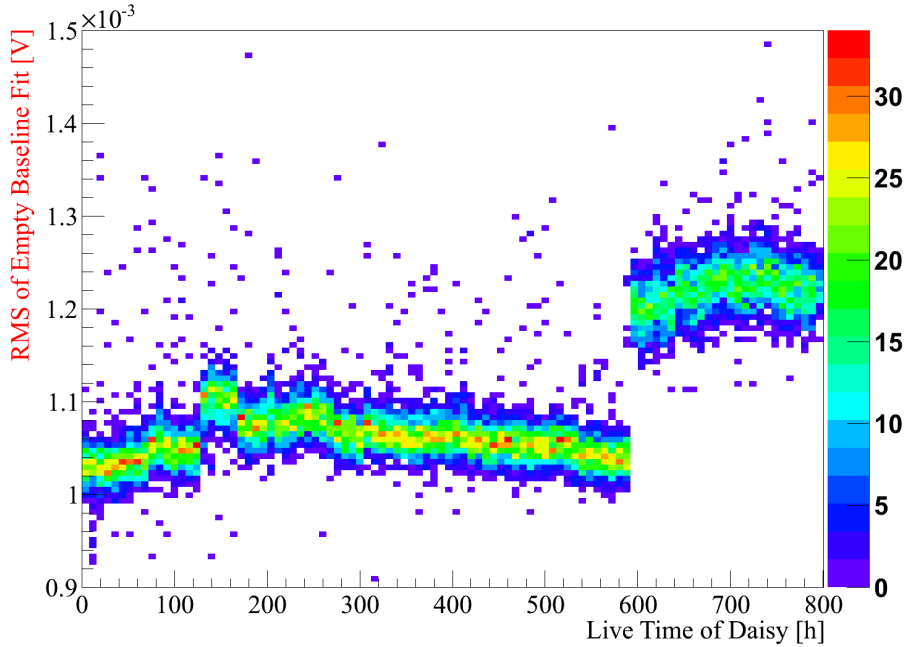
Use RMS of fit of empty baselines to detect changes in noise.

Empty Baselines



Use RMS of fit of empty baselines to detect changes in noise.





3D RMS Cut

Steps of new 3D RMS Cut

1. automatically find periods of constant noise
2. perform energy dependent cut, which is adapted automatically to different noise levels, within each period

Automatic Edge Finding

1. smooth/filter data $\rightarrow$ convolution with Gaussian ($[f * g](t)$)
2. calculate derivative
3. find extrema of derivative

Effective Implementation: Canny Edge Detection

- core element: combination of step one and two via convolution with derivative of Gaussian: $\frac{d}{dt}[f * g](t) = [f * \frac{d}{dt}g](t)$
- width of Gaussian (σ) determines sensitivity to noise

3D RMS Cut

Steps of new 3D RMS Cut

1. automatically find periods of constant noise
2. perform energy dependent cut, which is adapted automatically to different noise levels, within each period

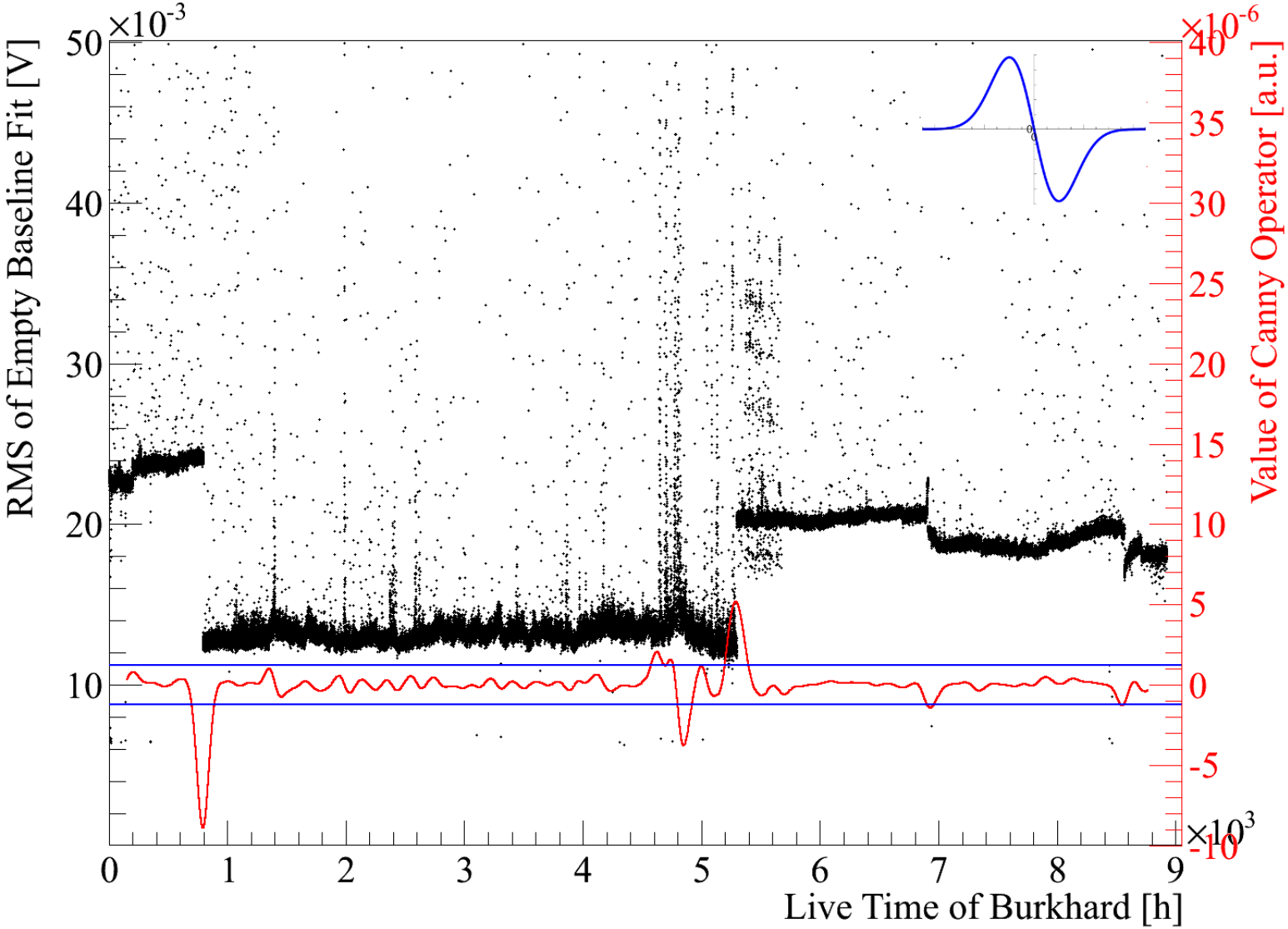
Automatic Edge Finding

1. smooth/filter data $\rightarrow$ convolution with Gaussian ($[f * g](t)$)
2. calculate derivative
3. find extrema of derivative

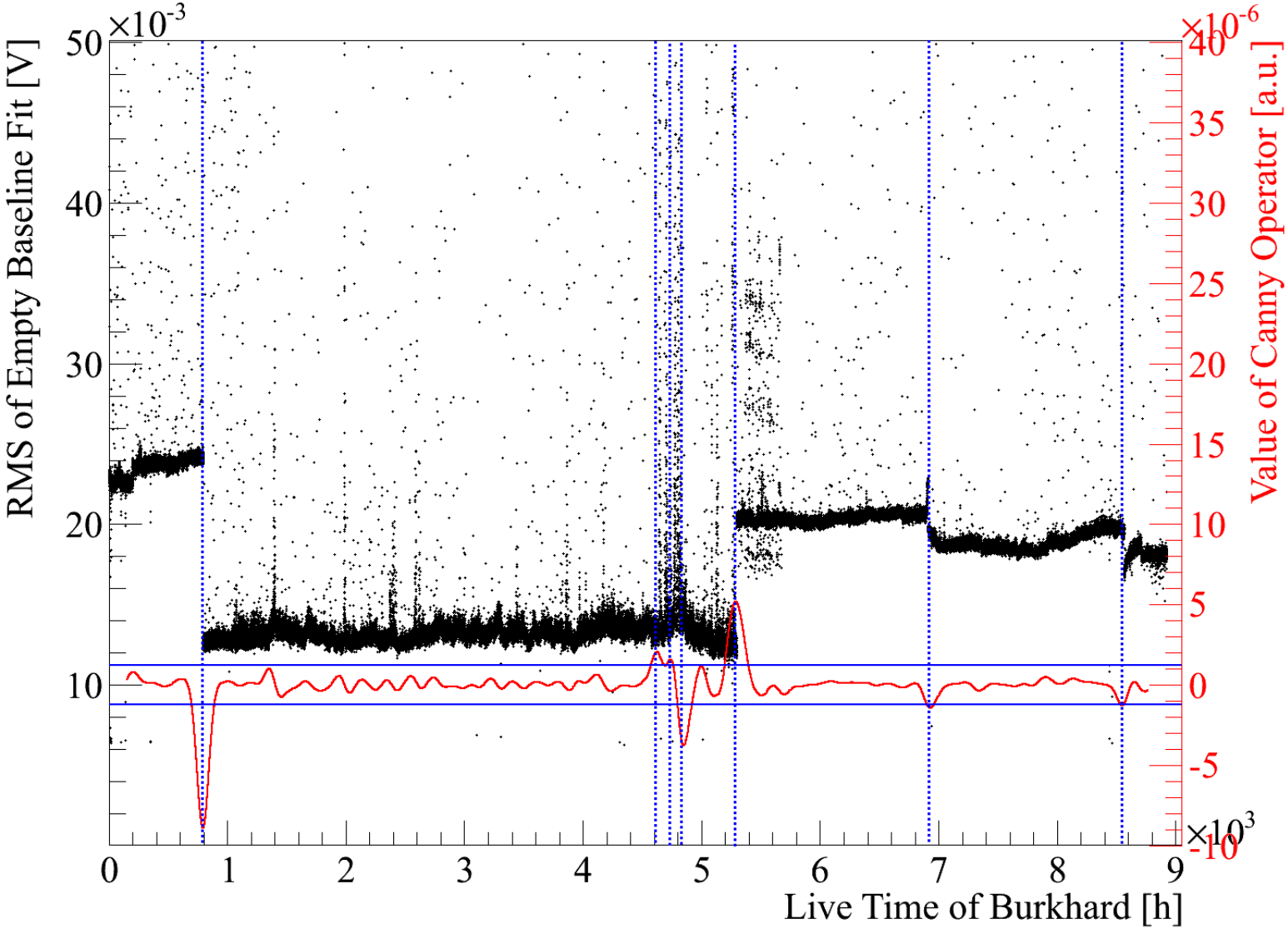
Effective Implementation: Canny Edge Detection

- core element: combination of step one and two via convolution with derivative of Gaussian: $\frac{d}{dt}[f * g](t) = [f * \frac{d}{dt}g](t)$
- width of Gaussian (σ) determines sensitivity to noise

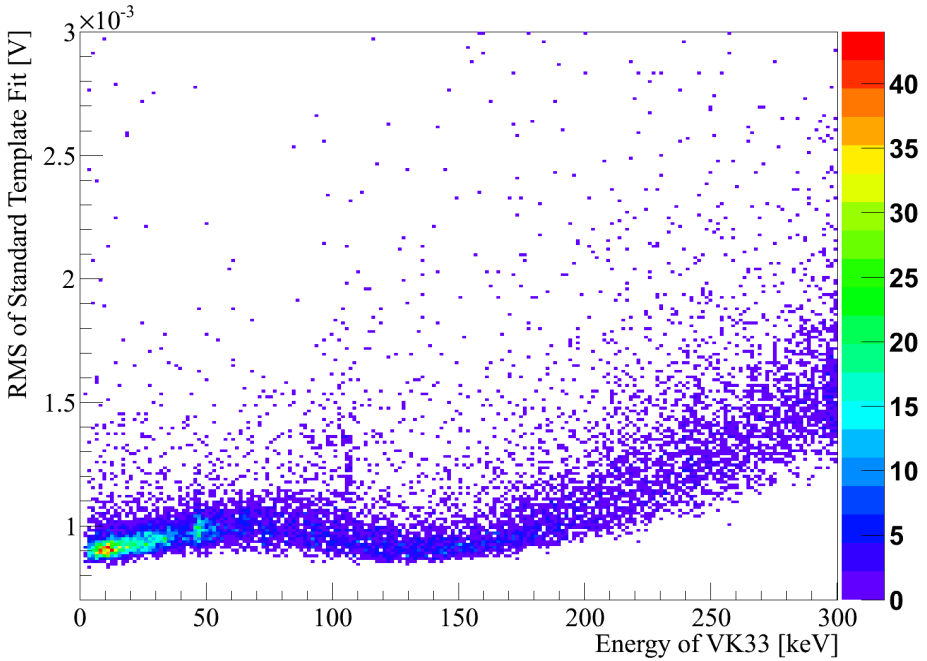
Automatic Edge Finding - Example



Automatic Edge Finding - Example



Energy Dependent RMS Cut



Method

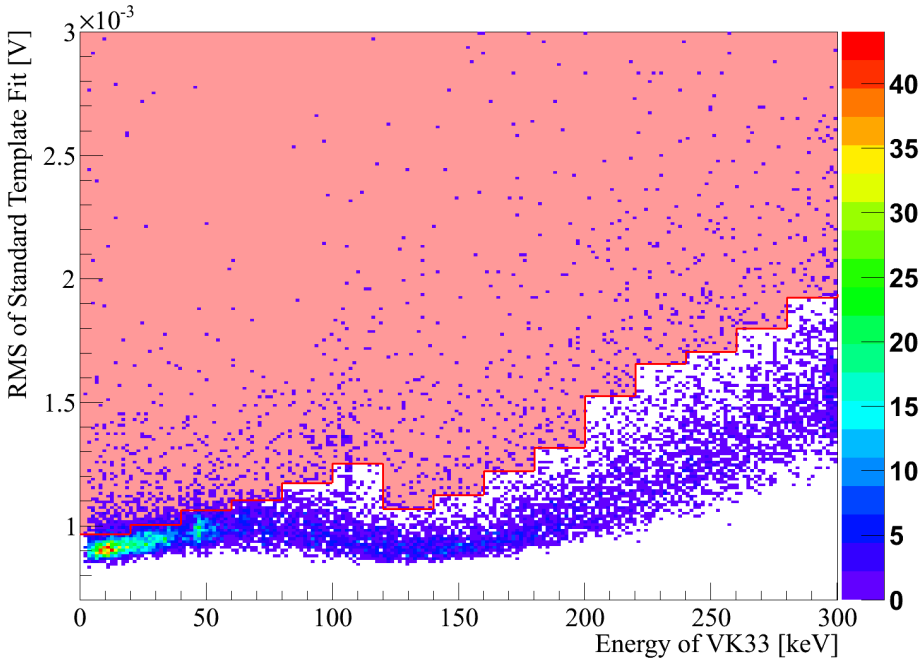
1. sort events in energy bins
2. remove same fraction of events in each bin

Parameters

bin width detector-specific (20keV)

fraction common for all detectors (15%)

Energy Dependent RMS Cut



Method

1. sort events in energy bins
2. remove same fraction of events in each bin

Parameters

bin width detector-specific (20keV)

fraction common for all detectors (15%)

Conclusion

3D RMS Cut

Steps:

1. automatic detection of periods of constant noise
2. sort events within each period in energy bins
3. remove same fraction of events within each bin

Advantages:

- Development of all relevant parameters on training set

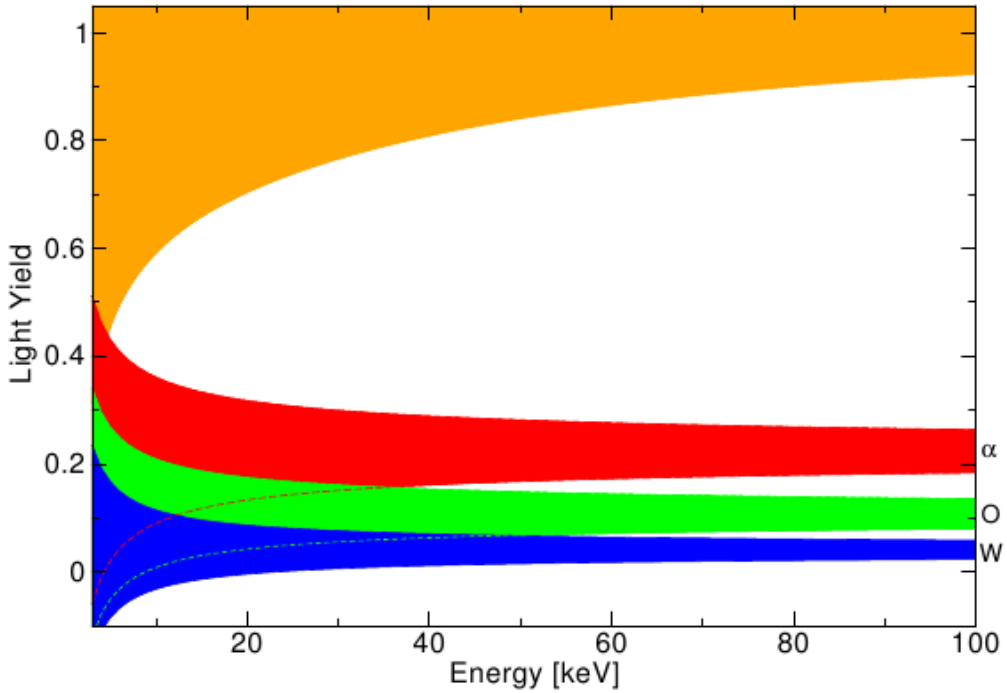
→ Blind analysis possible

- Common cut parameter for all detectors

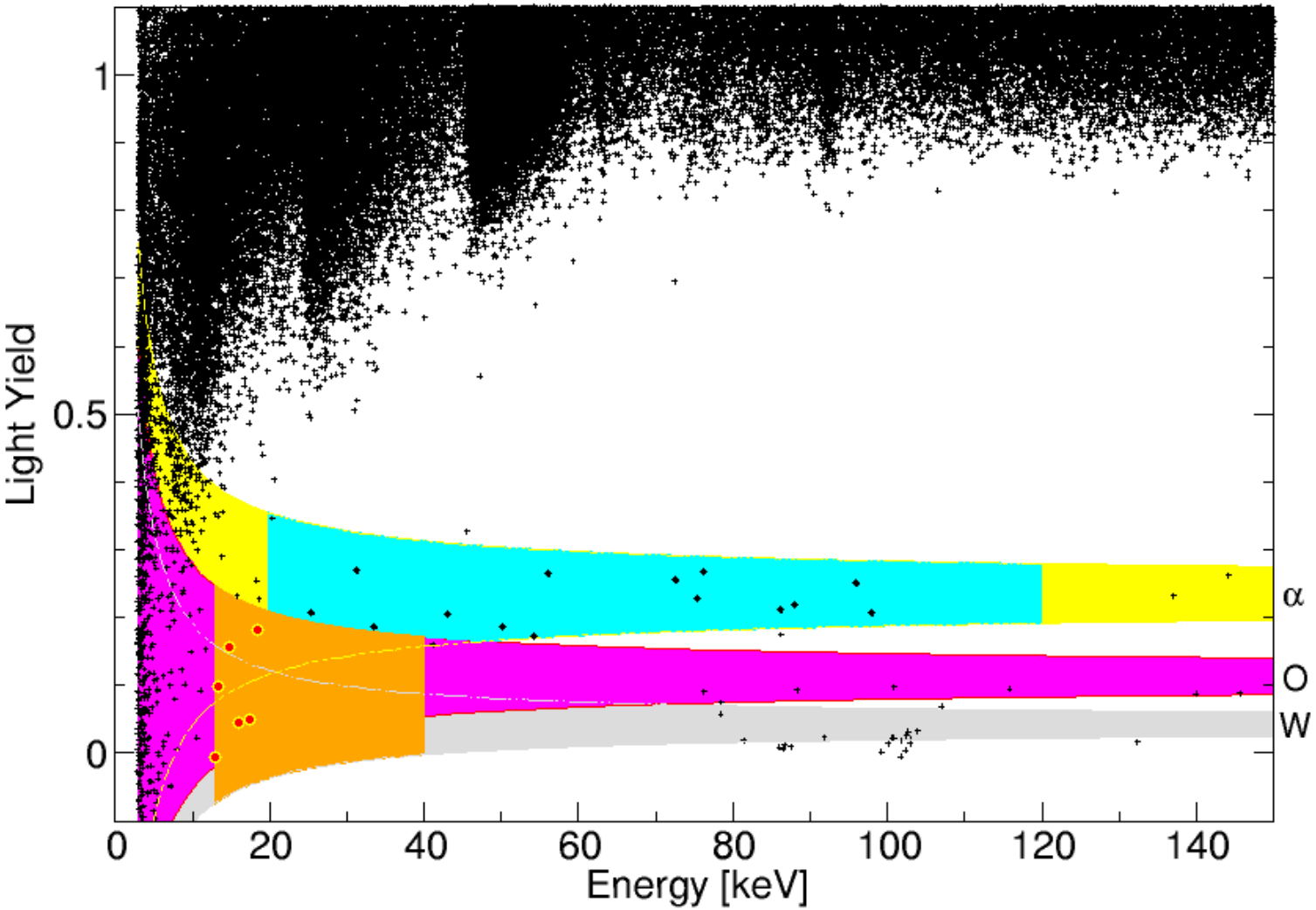
→ Enables to systematically study of influence of RMS cut on physics results

Active Background Discrimination

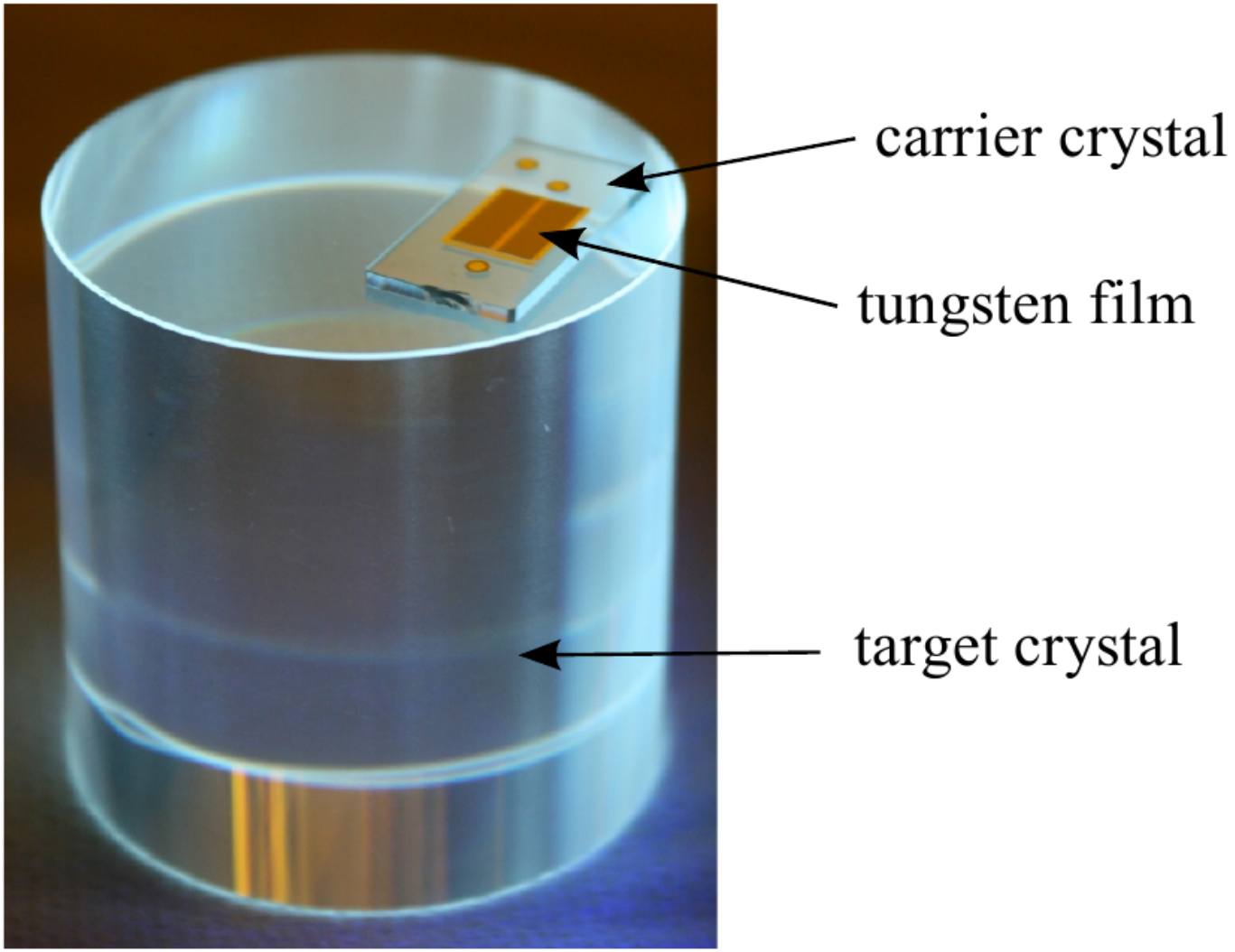
- use **light yield** $\frac{L}{E}$ to distinguish between event types



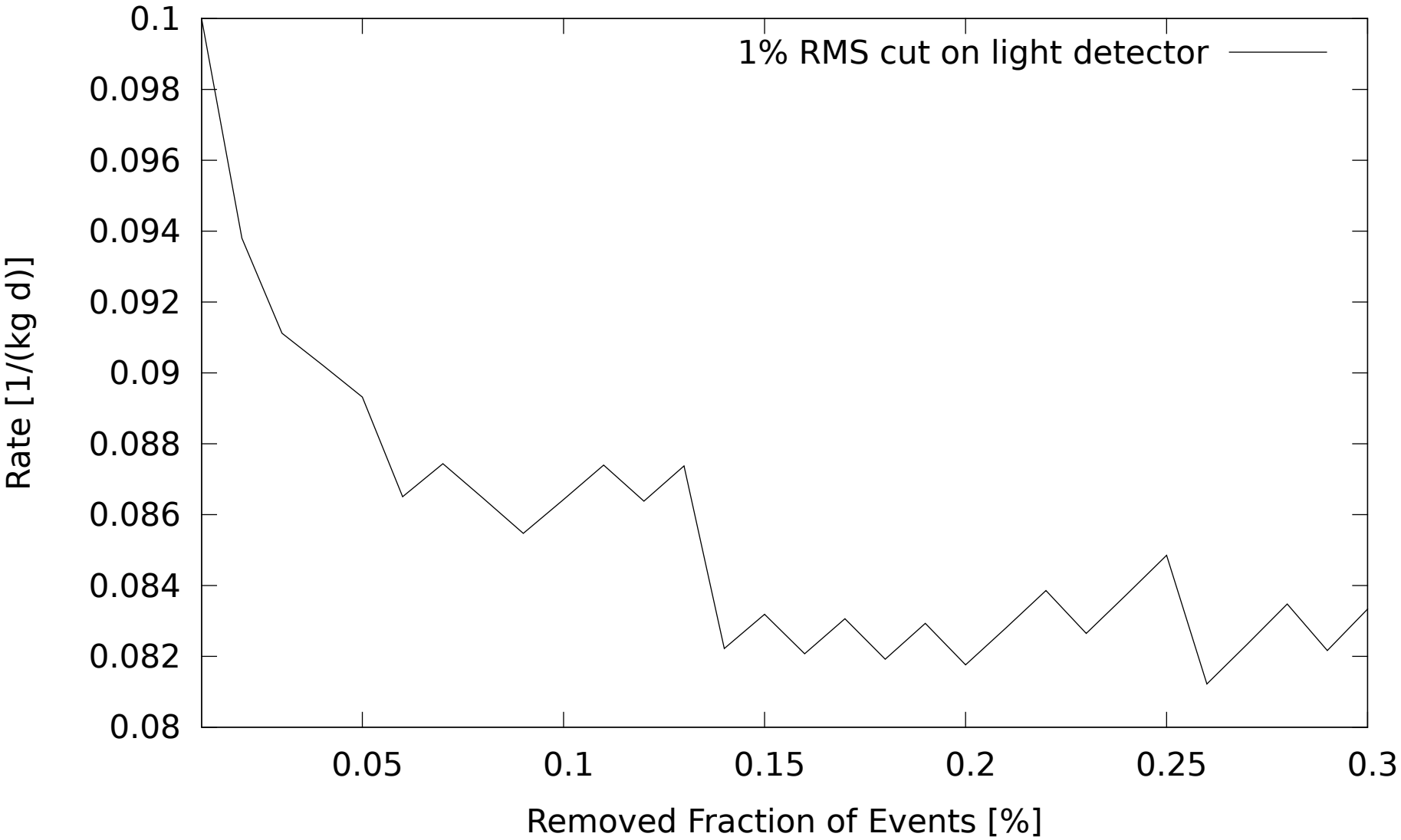
Ligh Yield - Energy Plane incl. Acceptance Region



Composite Target Crystal



RMS Sweep


1% RMS cut on light detector
Rate [1/(kg d)]
0.1
0.098
0.096
0.094
0.092
0.09
0.088
0.086
0.084
0.082
0.08
0.05
0.1
0.15
0.2
0.25
0.3
Removed Fraction of Events [%]